MOSFET - N-Channel Shielded Gate PowerTrench® 150 V, 14 mΩ, 61 A

NTMFS015N15MC

Features

- Small Footprint (5 x 6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low QG and Capacitance to Minimize Driver Losses
- 100% UIL Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS

Typical Applications

- Synchronous Rectification
- AC-DC and DC-DC Power Supplies
- AC-DC Adapters (USB PD) SR
- Load Switch

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	150	V
Gate-to-Source Voltage	Э		V _{GS}	±20	V
Continuous Drain Current R _{θJC} (Note 2)	Steady	teady - 2500	I _D	61	Α
Power Dissipation $R_{\theta JC}$ (Note 2)	State	T _C = 25°C	P _D	108.7	W
Continuous Drain Current $R_{\theta,JA}$ (Notes 1, 2)	Steady State		I _D	9.2	Α
Power Dissipation R _{θJA} (Notes 1, 2)	State	,,	P _D	2.5	W
Pulsed Drain Current	$T_C = 25^{\circ}C, t_p = 100 \ \mu s$		I _{DM}	302	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C
Single Pulse Drain-to-Source Avalanche Energy (I _L = 10 A _{pk} , L = 3 mH)			E _{AS}	150	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

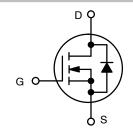
- 1. Surface-mounted on FR4 board using a 1 in 2 , 2 oz. Cu pad.
- 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
150 V	14 mΩ @ 10 V	61 A



N-CHANNEL MOSFET



MARKING DIAGRAM



1515MC = Specific Device Code = Assembly Location

Υ = Year W = Work Week ZΖ = Lot Traceability

ORDERING INFORMATION

С	Device	Package	Shipping [†]
NTMFS01	I5N15MC	Power 56	3000 / Tape
(Pb-Free,	/Halogen Free)	(PQFN8)	& Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

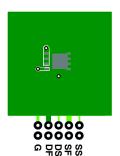
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ hetaJC}$	1.15	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{ hetaJA}$	50	

Parameter	Symbol	Test Condit	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS					1	<u>I</u>	<u>I</u> .
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		150			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 250 μA, ref	to 25°C		109		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 120 V				1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS					•	•	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$: 162 μA	2.5		4.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 162 μA, ref	to 25°C		-7.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	= 29 A		10.2	14	mΩ
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 8 V, I _D	= 15 A		11.1	16.2	mΩ
Forward Transconductance	9FS	V _{DS} = 10 V, I _D = 29 A			56		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE				•	•	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 75 V			2120		
Output Capacitance	Coss				595		pF
Reverse Transfer Capacitance	C _{RSS}				10.5		
Gate-Resistance	R_{G}				0.6	1.2	Ω
Total Gate Charge	Q _{G(TOT)}				27		
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = 10 V, V_{DS} = 75 V; I_D = 29 A			7		nC
Gate-to-Source Charge	Q_{GS}				11		
Gate-to-Drain Charge	Q_{GD}				4		
Plateau Voltage	V_{GP}				5.5		V
Output Charge	Q _{OSS}	V _{DD} = 75 V, V _G	_{iS} = 0 V		66		nC
SWITCHING CHARACTERISTICS (Note 3)					•	•	•
Turn-On Delay Time	t _{d(ON)}				16		
Rise Time	t _r	V _{GS} = 10 V, V _{DD}	n = 75 V,		5		
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 29 \text{ A}, R_G = 6 \Omega$			21		ns
Fall Time	t _f				4		1
DRAIN-SOURCE DIODE CHARACTERISTIC	s						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 29 A	T _J = 25°C		0.86	1.2	V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, V_{DD} = 75 \text{ V}$ $dI_S/dt = 300 \text{ A/}\mu\text{s}, I_S = 29 \text{ A}$			49		ns
Reverse Recovery Charge	Q _{RR}				197		nC
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, V_{DD} = 75 \text{ V}$ $dI_S/dt = 1000 \text{ A}/\mu\text{s}, I_S = 29 \text{ A}$			34		ns
Reverse Recovery Charge	Q _{RR}				345		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

- Switching characteristics are independent of operating junction temperatures.
 R_{θJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. R_{θCA} is determined by the user's board design.



a) 50°C/W when mounted on a 1 in² pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad of 2 oz copper.

TYPICAL CHARACTERISTICS

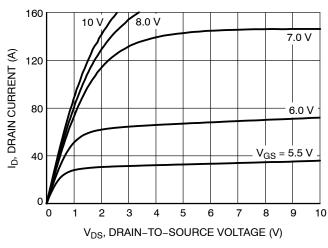


Figure 1. On-Region Characteristics

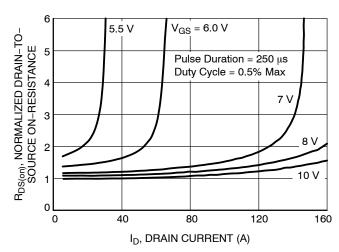


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

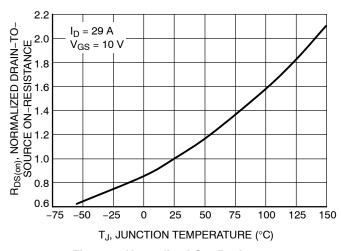


Figure 3. Normalized On–Resistance vs. Junction Temperature

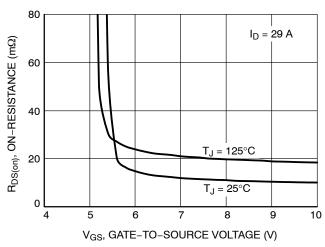


Figure 4. On-Resistance vs. Gate-to-Source Voltage

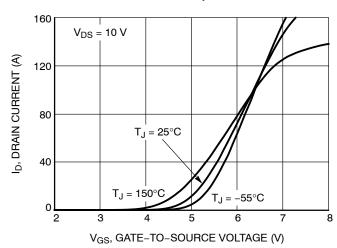


Figure 5. Transfer Characteristics

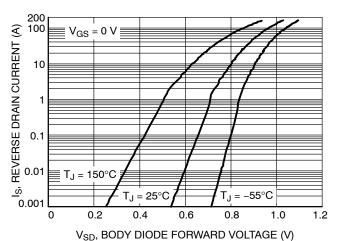


Figure 6. Source-to-Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS

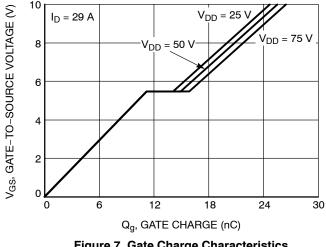


Figure 7. Gate Charge Characteristics

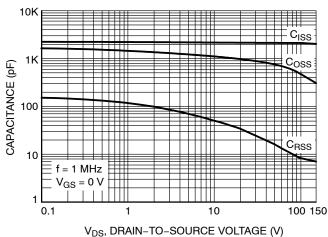


Figure 8. Capacitance vs. Drain-to-Source

Voltage

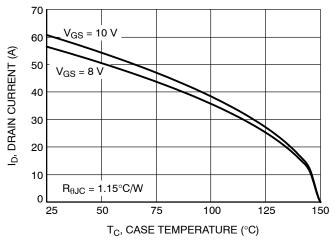


Figure 9. Drain Current vs. Case Temperature

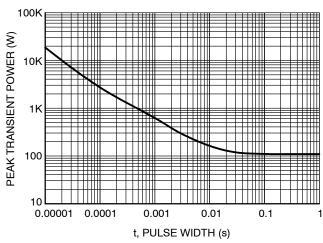


Figure 10. Peak Power

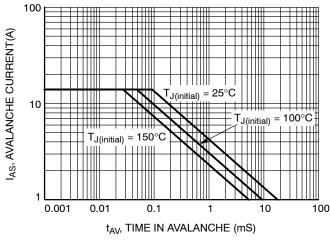


Figure 11. Unclamped Inductive Switching Capability

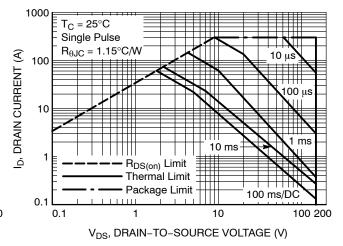


Figure 12. Forward Bias Safe Operating Area

TYPICAL CHARACTERISTICS

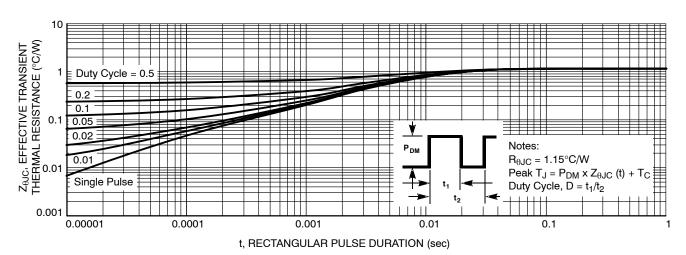
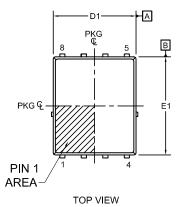
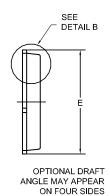


Figure 13. Transient Thermal Impedance



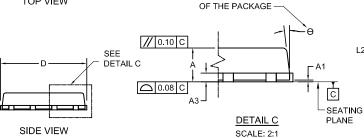
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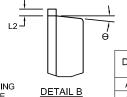




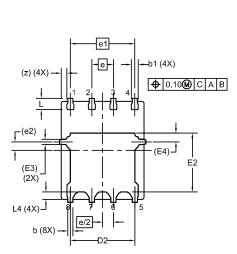
NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

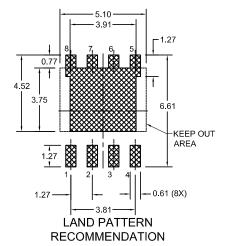




SCALE: 2:1



BOTTOM VIEW



*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

DIM	MILLIMETERS			
DIIVI	MIN.	NOM.	MAX.	
Α	0.90	1.00	1.10	
A1	0.00	-	0.05	
b	0.21	0.31	0.41	
b1	0.31	0.41	0.51	
A3	0.15	0.25	0.35	
D	4.90	5.00	5.20	
D1	4.80	4.90	5.00	
D2	3.61	3.82	3.96	
Е	6.05	6.15	6.25	
E1	5.70	5.80	5.90	
E2	3.38	3.48	3.78	
E3	0.30 REF			
E4	0.52 REF			
е	1.27 BSC			
e/2	(0.635 BS	С	
e1	3.81 BSC			
e2	0.50 REF			
L	0.51	0.66	0.76	
L2	0.05	0.18	0.30	
L4	0.34	0.44	0.54	
Z	0.34 REF			
θ	0°	-	12°	

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